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ASSISTANT COMMISSIONER FOR PATENTS
WASHINGTON, D.C. 20231

Re:

Serial No.:

09/531,163

Applicants:

Hiroyuki YANO, et al.

Filing Date:

March 17, 2000

For:

AQUEOUS DISPERSION, AQUEOUS DISPERSION

FOR CHEMICAL MECHANICAL POLISHING

USED FOR MANUFACTURE OF

SEMICONDUCTOR DEVICES, METHOD FOR

MANUFACTURE OF SEMICONDUCTOR

DEVICES, AND METHOD FOR FORMATION OF

**EMBEDDED WIRING** 

GAU: 2823

Examiner:

K. EATON

SIR:

Attached hereto for filing are the following papers:

## RESPONSE TO RESTRICTION REQUIREMENT

Our check in the amount of <u>\$-0-</u> is attached covering any required fees. In the event any variance exists between the amount enclosed and the Patent Office charges for filing the above-noted documents, including any fees required under 37 C.F.R. §1.136 for any necessary Extension of Time to make the filing of the attached documents timely, please charge or credit the difference to our Deposit Account No. <u>15-0030</u>. Further, if these papers are not considered timely filed, then a petition is hereby made under 37 C.F.R. §1.136 for the necessary extension of time. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

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Co/Election 7. Steptoe 4/19/01

100 CKET 100.: 0039-7632-0X

17 200 INSTHE UNITED STATES PATENT & TRADEMARK OFFICE

RE APPRICATION OF:

Hiroyuki YANO, et al.

: GROUP ART UNIT: 2823

SERIAL NO.: 09/531,163

FILED: March 17, 2000

: EXAMINER: K. EATON

FOR: AQUEOUS DISPERSION, AQUEOUS DISPERSION FOR CHEMICAL

MECHANICAL POLISHING USED FOR MANUFACTURE OF

SEMICONDUCTOR DEVICES, METHOD FOR MANUFACTURE OF SEMICONDUCTOR DEVICES, AND METHOD FOR FORMATION OF

EMBEDDED WIRING

## RESPONSE TO RESTRICTION REQUIREMENT

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Responsive to the Official Action dated March 20, 2001, Applicants elect, with traverse, Group I, Claims 1-39, for further prosecution.

## **REMARKS**

The Office has required restriction in the present application as follows:

Group I: Claims 1-39, drawn to an aqueous dispersion characterized by containing

polymer particles; and

Group II: Claims 40-43, drawn to a method for formation of embedded wiring.

Applicants elect, with traverse, Group I, Claims 1-39, for further prosecution.

Restriction is only proper if the claims of the restricted groups are either independent or patentably distinct. The burden of proof is on the Office to provide reasons and/or examples to support any conclusion with regard to patentable distinctness. MPEP §803.